	U.S. DEPARTMENT OF COMMERCE		ATTY DOCKET NO.		SERIAL	NO.	
	PATENT AND T	RADEMARK OFFICE	240416US0DIV	New Application			
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AQ	8-250020	09/27/96	Japan (w/English Abstract)			XX	
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*Examiner: In conformance	itial if r	eference is considered of considered. Include of	, whether or no copy of this form	t citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw li	rie through	citation if not in	